# **Power MOSFET**

# 40 V, 38 A, Single N-Channel, DPAK

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- Low Gate Charge
- These are Pb-Free Devices

#### **Applications**

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Paran	Symbol	Value	Units		
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain	Steady T <sub>C</sub> = 25°C		I <sub>D</sub>	38	Α
Current – $R_{\theta JC}$ (Note 1)	State	T <sub>C</sub> = 100°C	1	27	
Power Dissipation – R <sub>θJC</sub> (Note 1)	Steady State	, I a - 25°(; I		75	W
Pulsed Drain Current	t <sub>p</sub> =	= 10 μs	I <sub>DM</sub>	75	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 175	°C
Source Current (Body Diode)			IS	36	Α
Single Pulse Drain–to Source Avalanche Energy – ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_{PK}$ = 17 A, L = 1 mH, $R_G$ = 25 $\Omega$ )			EAS	150	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Units
Junction-to-Case (Drain)	$R_{\theta JC}$	2.0	°C/W

<sup>1.</sup> Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

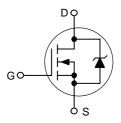


### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX (Note 1)	
40 V	21 m $\Omega$ @ 10 V	38 A	

#### N-Channel





#### DPAK CASE 369C STYLE 2

= Year = Work Week

WW = Work Week 5407N = Specific Device Code G = Pb-Free Device

MARKING DIAGRAM

> YWW 54

07NG

#### ORDERING INFORMATION

Device	Package	Shipping†
NTD5407NG	DPAK (Pb-Free)	75 Units / Rail
NTD5407NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

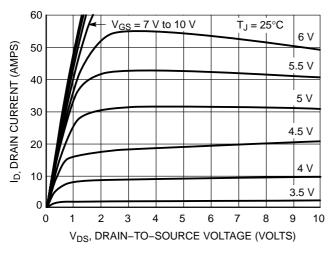
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				39		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 40 \text{ V}$	T <sub>J</sub> = 100°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{C}$	<sub>3S</sub> = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{I}$	_ = 250 μΑ	1.5		3.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	00 00 0			-6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 20 A		21	26	mΩ
		V <sub>GS</sub> = 5.0 V,	I <sub>D</sub> = 10 A		32	40	
Forward Transconductance	9FS	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 18 A		15		S
CHARGES AND CAPACITANCES	•		•				
Input Capacitance	C <sub>ISS</sub>				615	1000	pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = V_{DS} = 3$	: 1.0 MHz,		173		
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS - V	52 V		80		
Total Gate Charge	Q <sub>G(TOT)</sub>				20		nC
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 10 \text{ V, V}$ $I_{D} = 3$			2.25		
Gate-to-Drain Charge	$Q_{GD}$	5 – و.	· · · · · · · · · · · · · · · · · · ·		10.5		
SWITCHING CHARACTERISTICS, Vo	<sub>SS</sub> = 10 V (Note	3)					•
Turn-On Delay Time	t <sub>d(ON)</sub>				6.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V	nn = 32 V,		17		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 32 \text{ V},$ $I_D = 38 \text{ A}, R_G = 2.5 \Omega$			66		
Fall Time	t <sub>f</sub>				51		
SWITCHING CHARACTERISTICS, Vo	<sub>SS</sub> = 5 V (Note 3	)					•
Turn-On Delay Time	t <sub>d(ON)</sub>				10		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 5 \text{ V}, V_{I}$	on = 20 V.		175		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 20 \text{ A}, R_G = 2.5 \Omega$			13		
Fall Time	t <sub>f</sub>				23		
DRAIN-SOURCE DIODE CHARACTE	RISTICS (Note	2)	<u>.</u>				
Forward Diode Voltage	V <sub>SD</sub>	V <sub>G</sub> e = 0 V	T <sub>J</sub> = 25°C		0.9	1.1	V
	vGS = 0 v,		T <sub>J</sub> = 125°C		0.75		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 15 \text{ A}$			38		ns
Charge Time	t <sub>a</sub>				20.5		
Discharge Time	t <sub>b</sub>				17		
Reverse Recovery Charge	Q <sub>RR</sub>				40		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

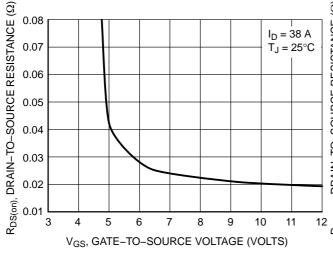
#### **TYPICAL PERFORMANCE CURVES**



60  $V_{DS} \ge 10 \text{ V}$ ID, DRAIN CURRENT (AMPS) 50 40 30 20  $T_J = 100^{\circ}C$ 10  $T_J = 25^{\circ}C$  $T_J = -55^{\circ}C$ 0 0 2 6 8 3 5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



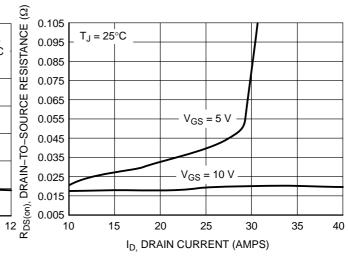
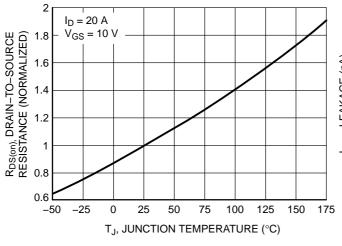


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



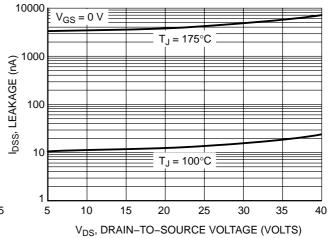
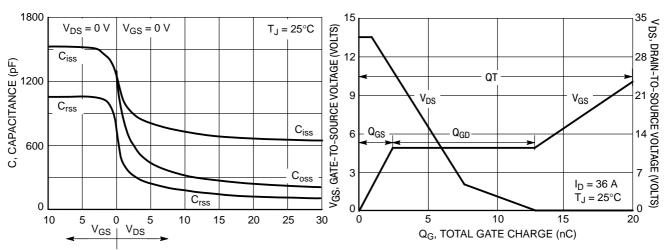


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

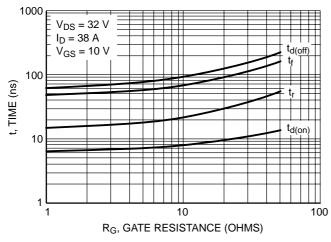


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

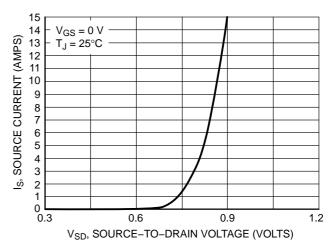
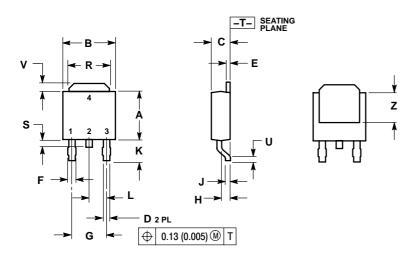


Figure 10. Diode Forward Voltage vs. Current

#### **PACKAGE DIMENSIONS**

#### **DPAK** CASE 369C-01 **ISSUE O**

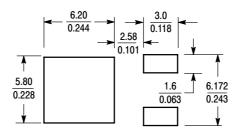


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180	BSC	4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090	BSC	2.29	BSC	
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### **SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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